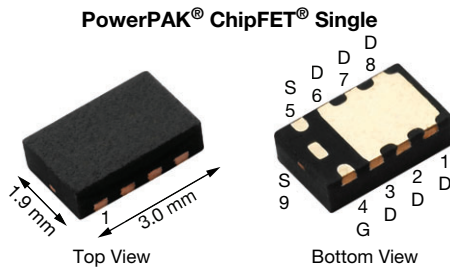


N-Channel 60 V (D-S) MOSFET



Marking code: AA

PRODUCT SUMMARY	
V_{DS} (V)	60
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 10$ V	0.034
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 4.5$ V	0.041
Q_g typ. (nC)	10.5
I_D (A) ^a	12
Configuration	Single

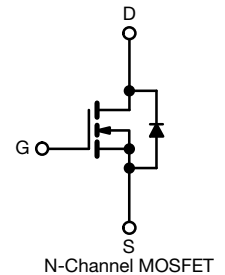
FEATURES

- TrenchFET® power MOSFET
- Thermally enhanced PowerPAK ChipFET package
 - Small footprint area
 - Low on-resistance
 - Thin 0.8 mm profile
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912


RoHS
 COMPLIANT
 HALOGEN
FREE

APPLICATIONS

- Load switch for portable applications
- DC/DC switch for low power synchronous rectification
- Intermediate switch driver for DC/DC applications



ORDERING INFORMATION	
Package	PowerPAK ChipFET
Lead (Pb)-free and halogen-free	Si5476DU-T1-GE3

ABSOLUTE MAXIMUM RATINGS ($T_A = 25$ °C, unless otherwise noted)				
PARAMETER		SYMBOL	LIMIT	UNIT
Drain-source voltage		V_{DS}	60	V
Gate-source voltage		V_{GS}	± 20	V
Continuous drain current ($T_J = 150$ °C)	$T_C = 25$ °C	I_D	12 ^a	A
	$T_C = 70$ °C		12 ^a	
	$T_A = 25$ °C		7 ^{b, c}	
	$T_A = 70$ °C		5.6 ^{b, c}	
Pulsed drain current		I_{DM}	25	A
Continuous source-drain diode current	$T_C = 25$ °C	I_S	12 ^a	A
	$T_A = 25$ °C		2.6 ^{b, c}	
Avalanche current	L = 0.1 mH	I_{AS}	15	mJ
Single pulse avalanche energy		E_{AS}	11.2	
Maximum power dissipation	$T_C = 25$ °C	P_D	31	W
	$T_C = 70$ °C		20	
	$T_A = 25$ °C		3.1 ^{b, c}	
	$T_A = 70$ °C		2 ^{b, c}	
Operating junction and storage temperature range		T_J, T_{stg}	-55 to +150	°C
Soldering recommendations (peak temperature) ^{d, e}			260	°C

THERMAL RESISTANCE RATINGS					
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT
Maximum junction-to-ambient ^{b, f}	$t \leq 5$ s	R_{thJA}	34	40	°C/W
Maximum junction-to-case (drain)	Steady state	R_{thJC}	3	4	

Notes

- Package limited
- Surface mounted on 1" x 1" FR4 board
- $t = 5$ s
- See solder profile (www.vishay.com/doc?73257). The PowerPAK ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection
- Rework conditions: manual soldering with a soldering iron is not recommended for leadless components
- Maximum under steady state conditions is 90 °C/W



SPECIFICATIONS ($T_J = 25\text{ }^\circ\text{C}$, unless otherwise noted)						
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static						
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0\text{ V}$, $I_D = 1\text{ mA}$	60	-	-	V
V_{DS} temperature coefficient	$\Delta V_{DS}/T_J$	$I_D = 250\text{ }\mu\text{A}$	-	55	-	mV/ $^\circ\text{C}$
$V_{GS(th)}$ temperature coefficient	$\Delta V_{GS(th)}/T_J$		-	-6.3	-	
Gate-source threshold voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$, $I_D = 250\text{ }\mu\text{A}$	1	-	3	V
Gate-source leakage	I_{GSS}	$V_{DS} = 0\text{ V}$, $V_{GS} = \pm 20\text{ V}$	-	-	± 100	nA
Zero gate voltage drain current	I_{DSS}	$V_{DS} = 60\text{ V}$, $V_{GS} = 0\text{ V}$	-	-	1	μA
		$V_{DS} = 60\text{ V}$, $V_{GS} = 0\text{ V}$, $T_J = 55\text{ }^\circ\text{C}$	-	-	10	
On-state drain current ^a	$I_{D(on)}$	$V_{DS} \geq 5\text{ V}$, $V_{GS} = 10\text{ V}$	25	-	-	A
Drain-source on-state resistance ^a	$R_{DS(on)}$	$V_{GS} = 10\text{ V}$, $I_D = 4.6\text{ A}$	-	0.028	0.034	Ω
		$V_{GS} = 4.5\text{ V}$, $I_D = 4.2\text{ A}$	-	0.033	0.041	
Forward transconductance ^a	g_{fs}	$V_{DS} = 15\text{ V}$, $I_D = 4.6\text{ A}$	-	20	-	S
Dynamic ^b						
Input capacitance	C_{ISS}	$V_{DS} = 30\text{ V}$, $V_{GS} = 0\text{ V}$, $f = 1\text{ MHz}$	-	1100	-	pF
Output capacitance	C_{OSS}		-	90	-	
Reverse transfer capacitance	C_{RSS}		-	55	-	
Total gate charge	Q_g	$V_{DS} = 30\text{ V}$, $V_{GS} = 10\text{ V}$, $I_D = 4.6\text{ A}$	-	21	32	nC
		$V_{DS} = 30\text{ V}$, $V_{GS} = 4.5\text{ V}$, $I_D = 4.6\text{ A}$	-	10.5	16	
Gate-source charge	Q_{gs}	$V_{DS} = 30\text{ V}$, $V_{GS} = 4.5\text{ V}$, $I_D = 4.6\text{ A}$	-	3.5	-	nC
Gate-drain charge	Q_{gd}		-	4.2	-	
Gate resistance	R_g		$f = 1\text{ MHz}$	-	3.3	
Turn-on delay time	$t_{d(on)}$	$V_{DD} = 30\text{ V}$, $R_L = 5.4\text{ }\Omega$, $I_D \cong 5.6\text{ A}$, $V_{GEN} = 4.5\text{ V}$, $R_g = 1\text{ }\Omega$	-	20	30	ns
Rise time	t_r		-	150	225	
Turn-off delay time	$t_{d(off)}$		-	20	30	
Fall time	t_f		-	60	90	
Turn-on delay time	$t_{d(on)}$	$V_{DD} = 30\text{ V}$, $R_L = 5.4\text{ }\Omega$, $I_D \cong 5.6\text{ A}$, $V_{GEN} = 10\text{ V}$, $R_g = 1\text{ }\Omega$	-	10	15	
Rise time	t_r		-	15	25	
Turn-off delay time	$t_{d(off)}$		-	22	40	
Fall time	t_f		-	10	15	
Drain-Source Body Diode Characteristics						
Continuous source-drain diode current	I_S	$T_C = 25\text{ }^\circ\text{C}$	-	-	12	A
Pulse diode forward current	I_{SM}		-	-	25	
Body diode voltage	V_{SD}	$I_S = 5.5\text{ A}$, $V_{GS} = 0\text{ V}$	-	0.85	1.2	V
Body diode reverse recovery time	t_{rr}	$I_F = 5.5\text{ A}$, $di/dt = 100\text{ A}/\mu\text{s}$, $T_J = 25\text{ }^\circ\text{C}$	-	25	50	ns
Body diode reverse recovery charge	Q_{rr}		-	25	50	nC
Reverse recovery fall time	t_a		-	19	-	ns
Reverse recovery rise time	t_b		-	6	-	

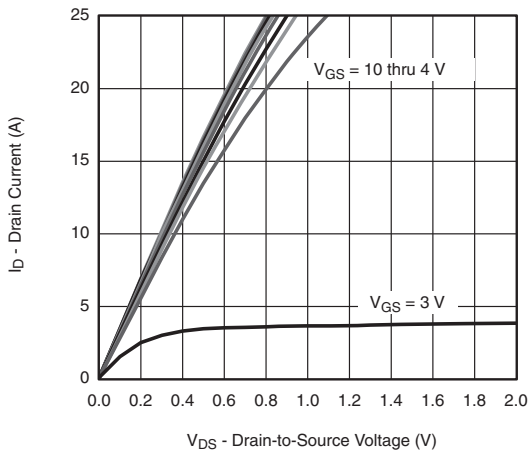
Notes

- a. Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$
b. Guaranteed by design, not subject to production testing

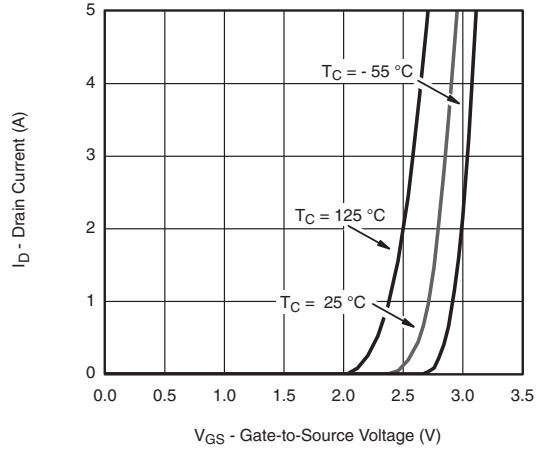
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



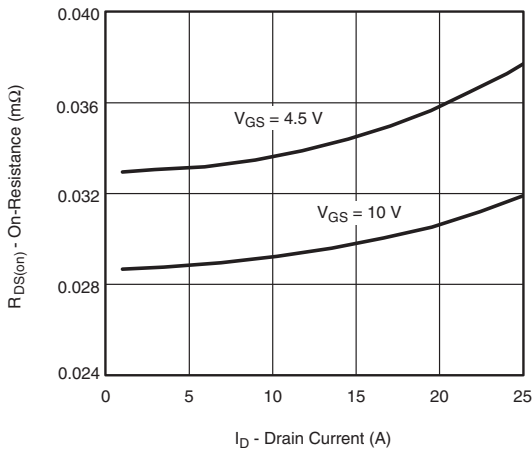
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



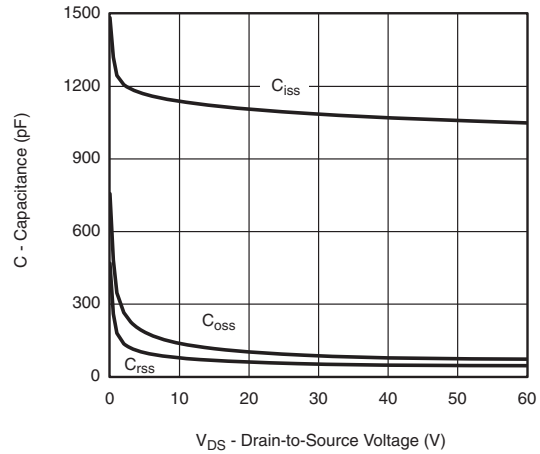
Output Characteristics



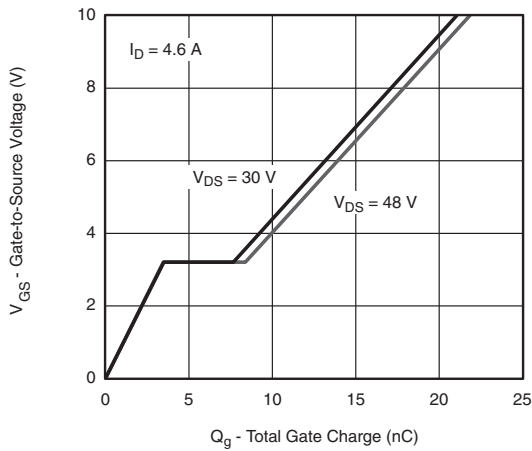
Transfer Characteristics



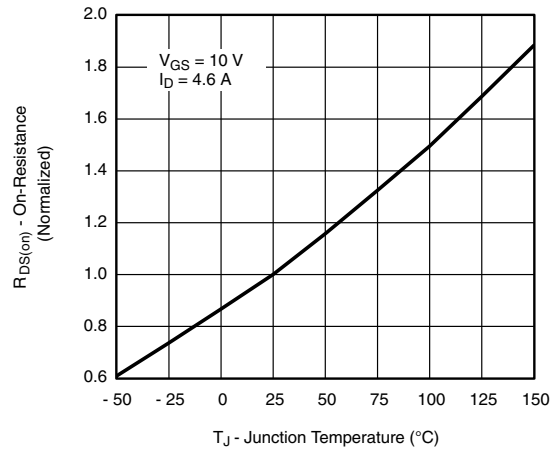
On-Resistance vs. Drain Current and Gate Voltage



Capacitance



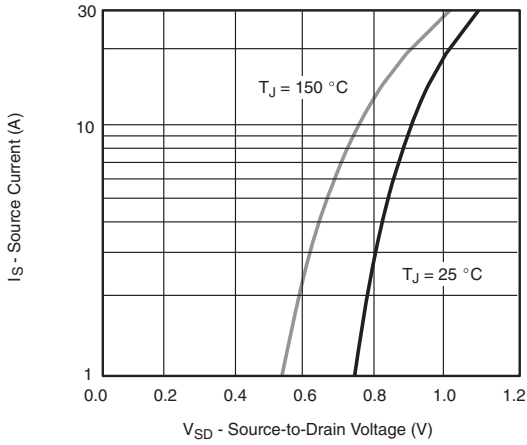
Gate Charge



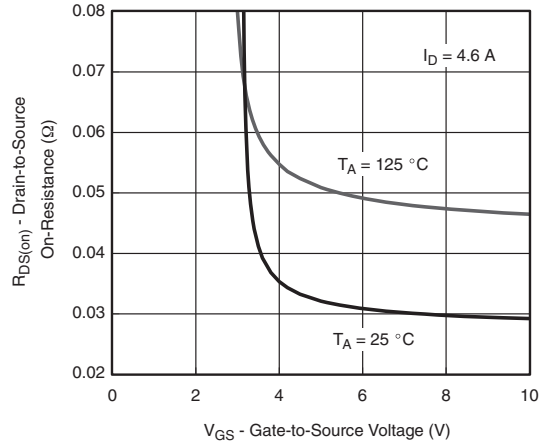
On-Resistance vs. Junction Temperature



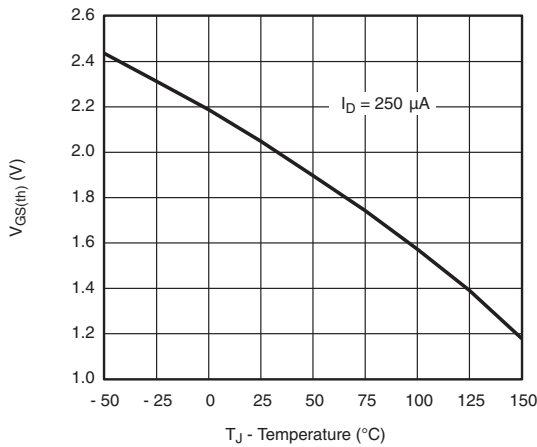
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



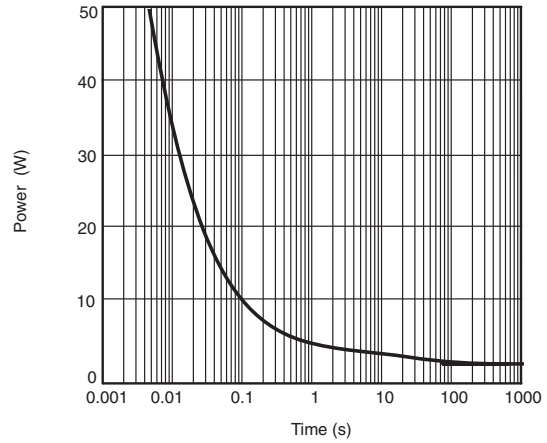
Source-Drain Diode Forward Voltage



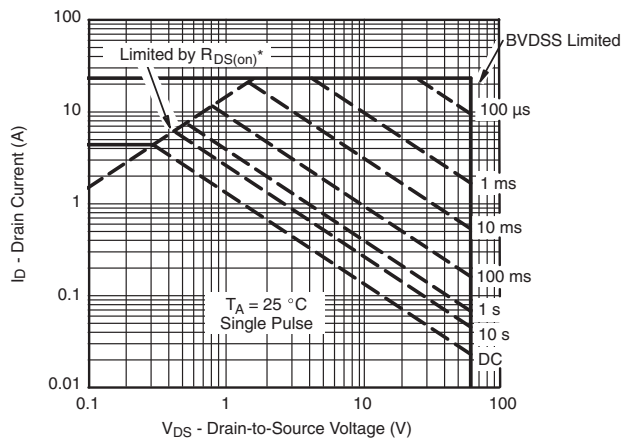
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



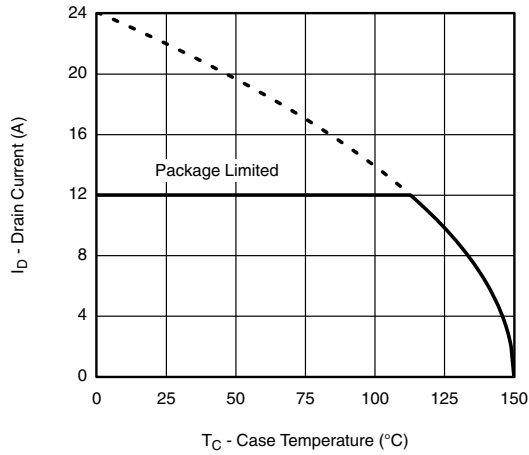
Single Pulse Power, Junction-to-Ambient



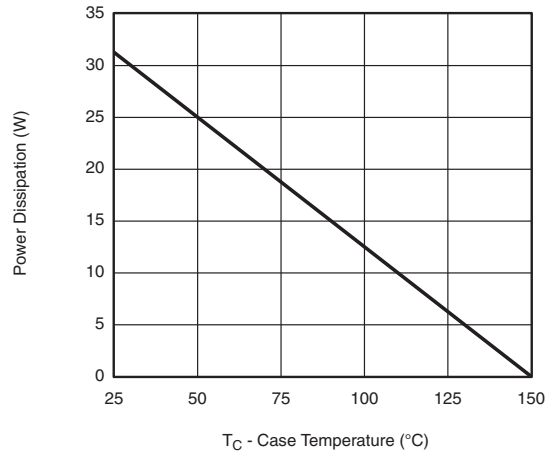
Safe Operating Area, Junction-to-Ambient



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating ^a



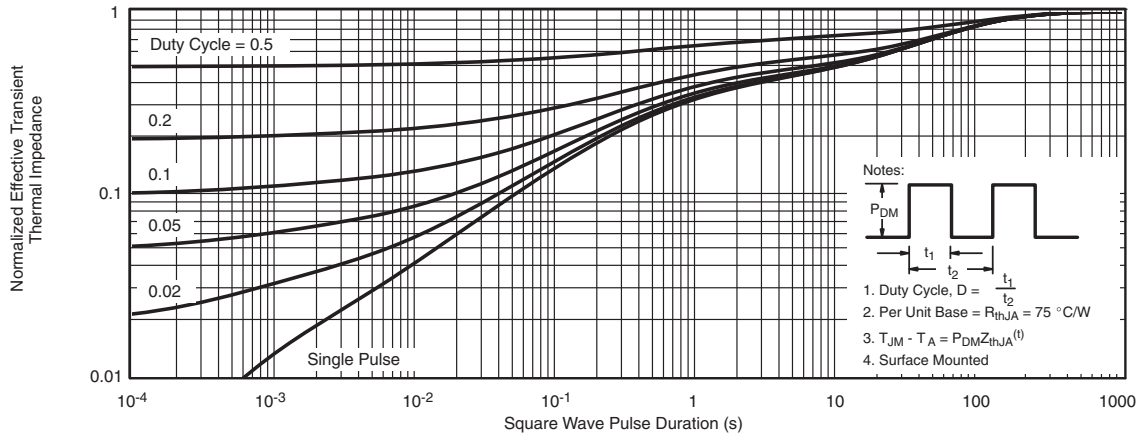
Power Derating

Note

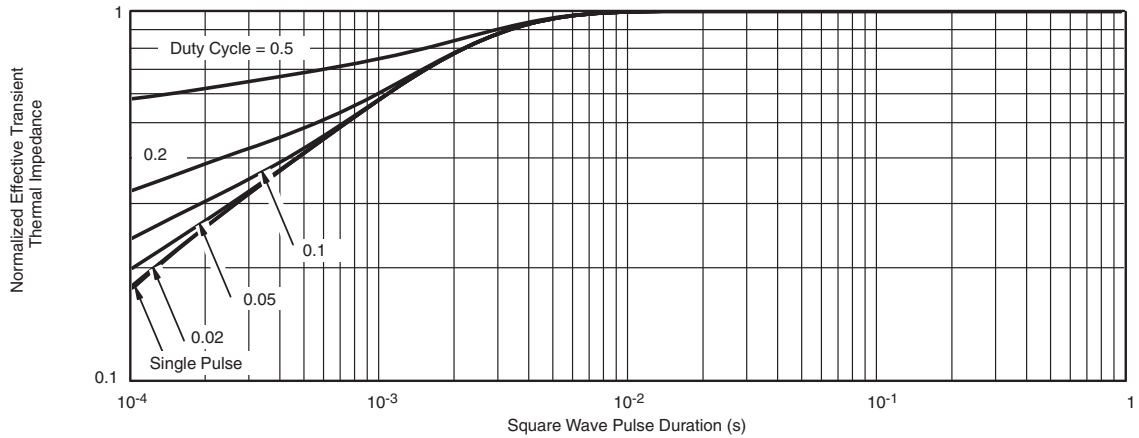
- a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



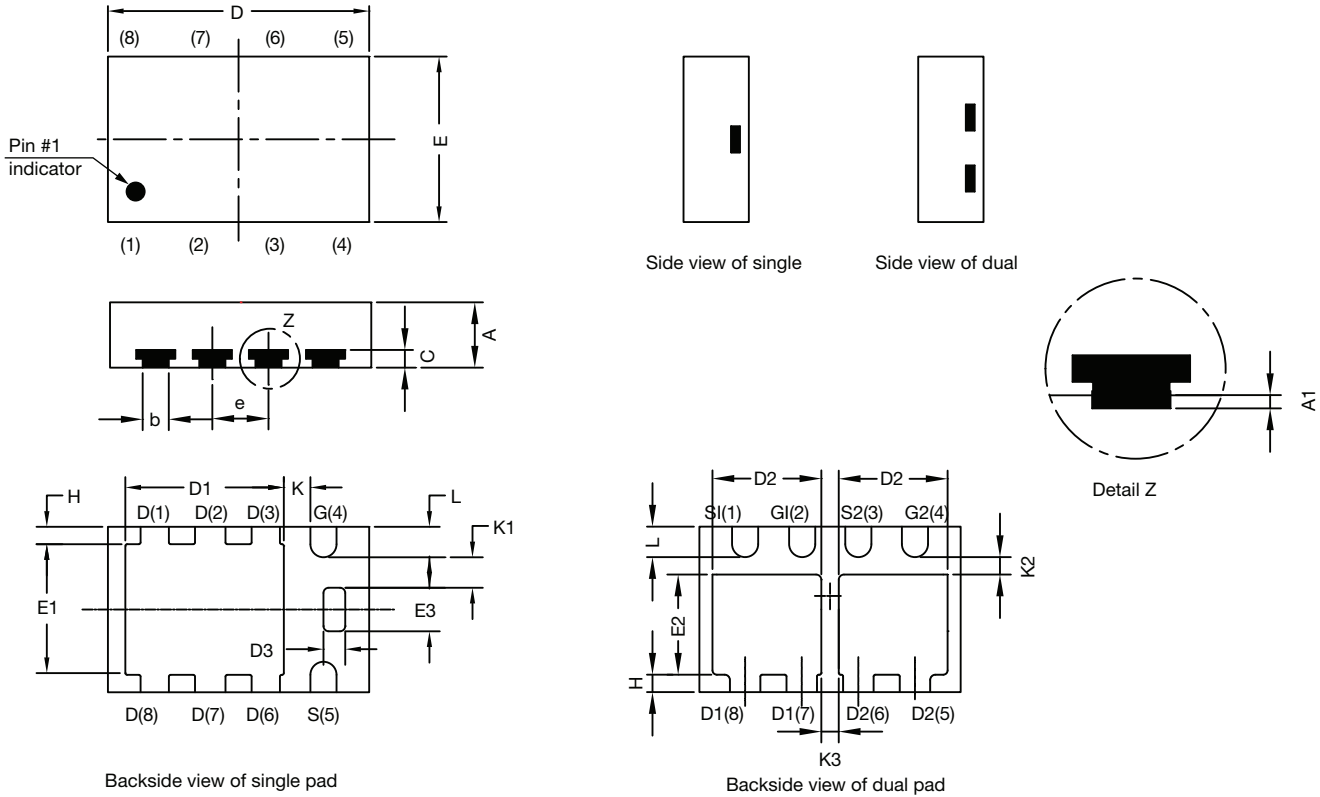
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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PowerPAK® ChipFET® Case Outline

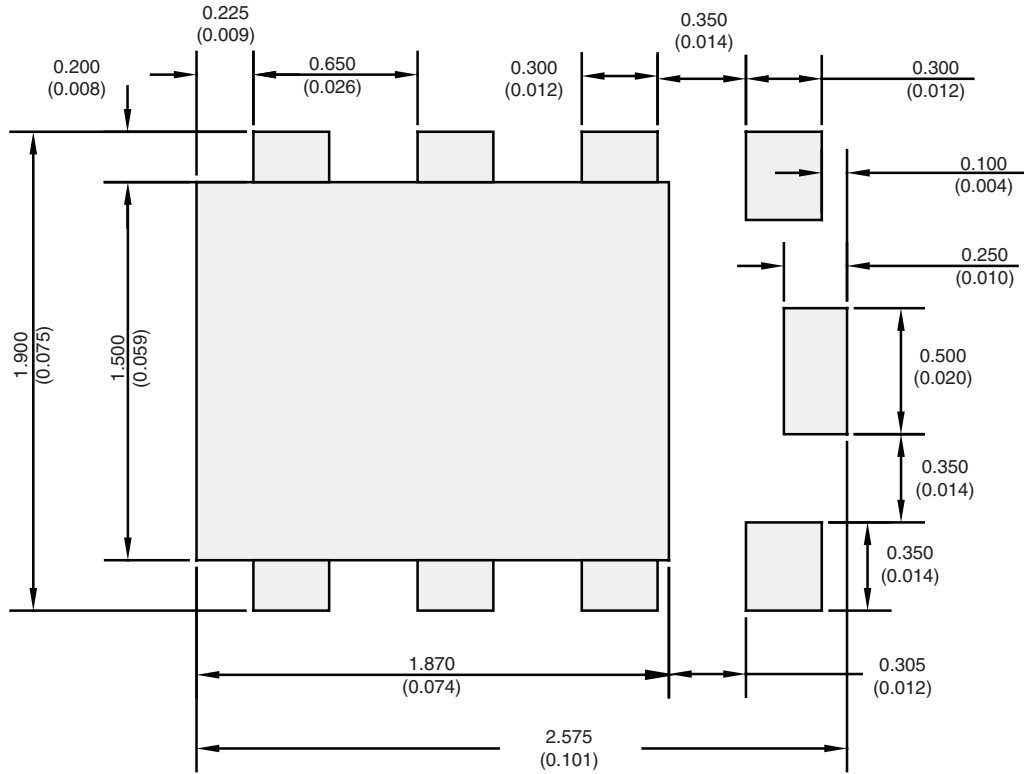


DIM.	MILLIMETERS			INCHES		
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.
A	0.70	0.75	0.85	0.028	0.030	0.033
A1	0	-	0.05	0	-	0.002
b	0.25	0.30	0.35	0.010	0.012	0.014
C	0.15	0.20	0.25	0.006	0.008	0.010
D	2.92	3.00	3.08	0.115	0.118	0.121
D1	1.75	1.87	2.00	0.069	0.074	0.079
D2	1.07	1.20	1.32	0.042	0.047	0.052
D3	0.20	0.25	0.30	0.008	0.010	0.012
E	1.82	1.90	1.98	0.072	0.075	0.078
E1	1.38	1.50	1.63	0.054	0.059	0.064
E2	0.92	1.05	1.17	0.036	0.041	0.046
E3	0.45	0.50	0.55	0.018	0.020	0.022
e	0.65 BSC			0.026 BSC		
H	0.15	0.20	0.25	0.006	0.008	0.010
K	0.25	-	-	0.010	-	-
K1	0.30	-	-	0.012	-	-
K2	0.20	-	-	0.008	-	-
K3	0.20	-	-	0.008	-	-
L	0.30	0.35	0.40	0.012	0.014	0.016
C14-0630-Rev. E, 21-Jul-14						
DWG: 5940						

Note

- Millimeters will govern

RECOMMENDED MINIMUM PADS FOR PowerPAK® ChipFET® Single



Recommended Minimum Pads
Dimensions in mm/(Inches)

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